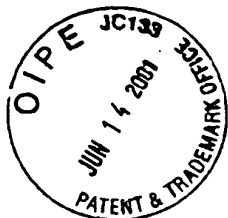


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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

REVOCATION AND GRANT OF POWER OF ATTORNEY

Box OIPE
Assistant Commissioner for Patents
Washington, DC 020231

Sir:

The applicant encloses for filing:

- Revocation and Grant of Power of Attorney

We do not believe any fees are due, however, please charge any fees due or credit any overpayments to Deposit Account 50-0369, Docket No. 21295/100. A duplicate copy of this page is enclosed.

Respectfully submitted,

Brown, Rudnick, Freed & Gesmer, P.C.

Maria M. Eliseeva

Maria M. Eliseeva

Reg. No. 43,328

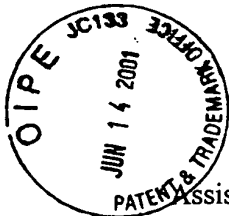
Customer No. 21710

Dated: June 7, 2001

Brown Rudnick Freed & Gesmer
One Financial Center
Boston, MA 02111
Tel: 617.856.8340
Fax: 617.856.8201

I certify that this document and fee, if any, is being deposited on June 7, 2001 with the U.S. Postal Service under 37 C.F.R. § 1.8, with sufficient First Class postage, and is addressed to Box Missing Parts, Assistant Commissioner for Patents, Washington, D.C. 20231.

Signed: *Michelle M. Guinazzo*



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Assistant Commissioner for Patents
Washington, DC 20231

Re: **Patents and Patent applications for**
Leica Microsystems International Holdings GmbH

Sir:

REVOCATION AND GRANT OF POWER OF ATTORNEY

Applicant hereby revokes all powers of attorney previously granted for the patents and patent applications listed below and appoints as its attorneys or agent, with full power of substitution and revocation, to prosecute the patents and patent applications and to transact all business in the United States Patent and Trademark Office connected therewith:

| | | | |
|--------------------|-----------------|-----------------|-----------------|
| Mark S. Leonardo | Reg. No. 41,433 | Peter B. Sorell | Reg. No. 44,349 |
| Brian L. Michaelis | Reg. No. 34,221 | Mark A. Hofer | Reg. No. 30,068 |
| David D. Lowry | Reg. No. 38,538 | Barry C. Nelson | Reg. No. 46,951 |
| Joseph P. Quinn | Reg. No. 45,029 | John P. Serio | Reg. No. 39,023 |
| Maria M. Eliseeva | Reg. No. 43,328 | Lucy Elandjian | Reg. No. 46,164 |
| John J. Penny, Jr. | Reg. No. 36,984 | | |

All of Brown, Rudnick, Freed & Gesmer, One Financial Center, Boston, MA 02111

| Serial No. | Filing Date | Patent No. | Title |
|------------|-------------|------------|--|
| 09/476,649 | 12/31/1999 | | Method and System for Compensating Intensity Fluctuations of an Illumination System in a Confocal Microscope |
| 09/476,589 | 12/31/1999 | | Method and System for Processing Scan-Data from a Confocal Microscope |
| 09/476,588 | 12/31/1999 | | Method and System for User Guidance in Scanning Microscopy |
| 09/439,876 | 11/12/1999 | | Refractometer and Method for Qualitative and Quantitative Measurements |
| 09/678,129 | 10/04/2000 | | Device for Changing Lenses in a Microscope with a Fixed Stage |
| 09/676,836 | 09/29/2000 | | Refractometer for Monitoring Water Content in Fluids |
| 09/681,008 | 11/15/2000 | | Apparatus for Optical Scanning of Multiple Specimens |
| 09/681,014 | 11/20/2000 | | Apparatus for Beam Deflection |
| 09/681,019 | 11/28/2000 | | Method for Optical-Light Scanning of a Specimen and Scanning Microscope for Scanning a Specimen |
| 09/700,770 | 11/08/2000 | | Method and Apparatus for Measuring Thickness of |

#3 / Revoked / Appointed
by assignee
6/22/01
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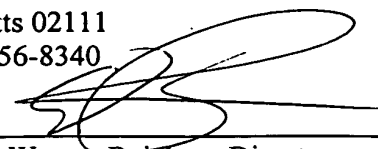
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| | | | |
|------------|------------|-----------|---|
| 09/681,051 | 12/10/2000 | | Microscope and Method for Analyzing Acquired Scan Data |
| 09/681,109 | 01/10/2001 | | Arrangement for Detecting Fluorescent Light from a Plurality of Sample Points |
| 09/681,186 | 02/14/2001 | | Method for Examining Structures on a Semiconductor Substrate |
| 09/825,273 | 04/03/2001 | | Apparatus for Combining Light and Confocal Scanning Microscope |
| 09/826,712 | 04/05/2001 | | Double Confocal Scanning Microscope |
| 09/097,368 | 06/15/1998 | 5,969,808 | Brake Check Handheld Refractometer |
| 09/238,547 | 01/28/1999 | 6,034,762 | Brake Check Handheld Refractometer |
| 09/464,559 | 12/16/1999 | | Displaceable x/y Coordinate Measurement Table |
| 09/681,096 | 01/04/2001 | | Measuring Instrument and Method for Measuring Features on a Substrate |
| 60/142,207 | 07/02/1999 | | Refractometer and Method for Sensitive and Quantitative Measurements |
| 60/108,414 | 11/13/1998 | | Refractive Index Based on Biosensor Device |
| 60/157,436 | 10/04/2000 | | Device for Changing Lenses in a Microscope with a Fixed Stage |
| 60/182,375 | 02/14/2000 | | Method for Examination of Operable Integrated and non-integrated Electronic Circuits |
| 60/054,330 | 07/31/1997 | | Brake Check Handheld Refractometer |
| 60/176,284 | 01/14/2000 | | Apparatus and Method for Determining Structures on a Substrate |
| 60/170,243 | 12/10/1999 | | System and Method for Evaluation Registered Scan Data and a Scanning Fluorescent Microscope with a method for Evaluation Registered Scan Data |
| 60/164,162 | 11/08/1999 | | Method and Device for Measuring The Thickness of Transparent Layers |

Applicant hereby requests that all correspondence be directed to

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Dated: May 29/2001


Dr. Werner Reichert, Director
Corporate Patent and Trademark Department

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